Transverse Impedance Localization Update

N.Biancacci



- Method
- Measurements in PS
- Measurements in SPS
- Measurements in LHC

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Outline

- Transverse impedance localization method.
- Observable: phase advance
 - Accuracy of phase advance detection for noisy signals.
 - Accuracy of slopes for measurements with error bars.
 - Impedance induced phase advance beating
- Application to the PS
 - Measurement of local quadrupolar orbit errors.
 - Measurements with single bunch, injection, V-plane.
- Application to the SPS
 - BPM system.
 - Measurement with single bunch, injection, V-plane.
- Application to the LHC
 - Status of analysis.
- Conclusion and overview.

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Transverse Impedance Localization Method

The transverse beam coupling impedance can be measured both globally and locally:



The method for local measurements was proposed and applied by G. Arduini et al. in 2004 and 2009 in SPS [1,2] and benchmarked with HEADTAIL.

[1] "Localizing impedance sources from betatron-phase beating in the CERN SPS", G. Arduini, C. Carli , F. Zimmermann EPAC'04.

[2] "Transverse Impedance Localization Using dependent Optics" R.Calaga et al., PAC'09.

The aim of the measurement is: correlating the phase advance beating variation with intensity with a local source of impedance.

In "optical" terms, an impedance would behave as a (de)focusing intensity dependent quadrupole.



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Observable: Phase advance

The uncertainty chain:



Accuracy of phase advance detection for noisy signals

Numerical estimation of phase uncertainty on simulated signal:

- Take 2 aleatory sinusoidal signals, with additive Gaussian noise of sigma σ_n , same tune and fixed phase advance $\Delta \varphi$, amplitude A=1 (NB: NSR= $\sigma_n/A=\sigma_n$ in this case).
- Run 100 times and measure the phase advance.
- Measure the standard deviation $\sigma_{\Delta\varphi}$ for the phase advance (accuracy in measurements).
- Fit.



Accuracy of phase advance slope measurements

Given a set of **M** measurements of $\Delta \varphi$ with equal error bars $\sigma_{\Delta \varphi}$, obtained along an intensity scan **X**, we can calculate $\sigma_{\Delta \varphi}$ using standard straight line least squares:

$$\sigma_{\frac{\Delta\varphi}{\Delta N}} = \frac{\sigma_{\Delta\varphi}}{\sigma_X \sqrt{M}}$$
 with σ_X standard deviation of the intensity scan X.

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Comparing with the previous formula one has:



To be reduced (noise level, kicker strength, BPMs gain, BPM transfer function)

To be increased: M= number of measurements. Usually a 100 points it's the case.

To be increased: It is the width of the scan of intensity. Upper threshold can be TMCI. Lower is BPM sensitivity.

To be increased: N=Number of turns. Depends on ability on hardware and data trasmission from BPM to storage.

Impedance induced phase advance beating

A phase beating is induced by impedance kicks similarly to what is done by a quadrupolar kick. From standard formulas we can calculate the phase beating amplitude and therefore compare it with the accuracy we can get in measurements. **Example:** PS kickers



1) Calculate impedance: Tsutsui's model for the kickers.

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1) Calculate impedance: Tsutsui's model for the kickers.

2) Merging Sacherer formula and phase beating formula [1] we calculate the beat amplitude from impedances as:

$$A = \frac{q^2}{(2\pi)^2 T_0} \frac{\sqrt{\pi} \operatorname{Im}\{Z_{eff}\}}{\gamma m_p \omega_0 Q_0 \sigma_z} \left(\frac{\delta_s}{2} + \frac{1}{2\sin(2\pi Q_0)}\right)$$

and compare with measurements and the estimation:

$$\sigma_{\frac{\Delta\varphi}{\Delta N}} = \frac{1.2 \ NSR}{\sigma_X \sqrt{N} \sqrt{M}}$$

[1] "Localization of transverse impedance sources in the SPS using HEADTAIL macroparticle simulations" IPAC12, N.Biancacci et al.





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QSE current variation

Method validation:

- take a couple of quadrupoles.
- vary their current in order to provoke a tune shift of ~ 0.02 .
- Try to localize back the quadrupoles.



QSE current variation

East hal

South hall

North ho

LEIR

Linac III

Method validation:

- take 2 QSE quadrupoles.
- vary their current in order to provoke a tune shift of ~0.02.
- Try to localize back the quadrupoles.



QSE current variation

From the tune shift we verified that a considerable scan was achieved.



15

20

0.235

0.23

0.225

0.22

0,215

A

5

10

Current [A]

An error in a QSE quadrupole provokes a beat of amplitude A~7.5e-4. This is well within the accuracy limit. QSE are 2, so the beating waves can interact constructively or destructively. East hal

South hall

North ho

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QSE current variation



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The two quadrupoles provoke beating waves that interact constructively: sum of beating amplitude A~1.5e-3 agrees with the measured one.

Both slope and reconstruction are good.

Even if it's not a really "intensity dependent" experiment from a beam point of view, it proves that the reconstruction method can work.

Measurement with single bunch V plane

- The measurement with single bunch at injection energy 2GeV, was done with a TOF beam.
- Intensity scan from 1e12 to 6e12 ppb.
- TFB was used as vertical kicker.
- The smallest bunch length is 90ns (4 σ) with 200kV in 10MHz cavities.





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Measurement with single bunch V plane —









- Measurement is rather clean.
- The step like behaviour expected from HEADTAIL simulation is smoothed.
- Probably SC contribution?
- Resistive wall tune shift contribution should be cut out?

* Impedance calculated with Tsutsui's model

Reconstruction of PS-30-01-2013_V3:



Measurements reproducibility: 10/02 Vs 30/01,



Trying with tunes closer to half resonance Qy~0.5, the signal should increase.

$$A = \frac{q^2}{(2\pi)^2 T_0} \frac{\sqrt{\pi} Im\{Z_{eff}\}}{\gamma m_p \omega_0 Q_y \sigma_z} \left(\frac{\delta_s}{2} + \frac{1}{2 \sin(2\pi Q_y)} \right) \longrightarrow \begin{cases} 0.26 \to x1 \\ 0.36 \to x1.2 \\ 0.46 \to x4 \end{cases}$$

But the optics model is very compromised close to the resonance due to the natural optics errors.

300

400

500

600

-0.5

-1

-1.5

0

100

200

Measurements reproducibility: 30/01 Qy~0.26 Vs 10/02 Qy~0.36









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But it was worth! Many thanks Christian and Stephen!



A scan in intensity is done from 4e10 to 1.6e11 for a LHCINDIV type of beam at flat bottom (26GeV).



NB: Chromaticity is set almost to zero in Y plane. At high intensity measurement are taken with beam almost unstable in order to get the maximum number of turns.



- ~1000 turns are analyzed.
- Phases are collected only for signals with NSR<20%.



- Finally we get a slope. It exhibits the typical decreasing behavior.
- More refined analysis is ongoing to recover the empty sections (NSR>20...)
- Some hint on impedance position can already be seen.



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MD overview:



B1 and B2 unstable due to low chromaticity. We had to increase of 6 units both beams.

Good measurements.

First scan as example:



Steps obtained by scraping the beam during the kick

Bunch length decreases due to the scraping.

AC dipole oscillation looks very clean





0.34 0.33 0.32 0.31 0.31 0.3 0.29 0.5 1 1.5 2 2.5 Intensity [1e11 ppb]

> The tune seems to be locked at 0.3085. This behaviour is still not clear.

- Is it related to the scraping ?
- Is it an AC dipole unstable line?
- Other effects ?



Accumulated phase advance slopes analysis on going....

Resuming:

- A better understanding of the major constraints in the impedance localization measurement has been achieved.
- Measurements for PS are well between error bars but reconstruction is not straightforward.
- SPS measurements are still on going, especially for Q20 (see backup). Trials with moving collimators are on going.
- Measurements for LHC have still to be analysed in detail.

Plan:

- Better understanding/implementation of the reconstructing algorithm (maybe the response matrix is too simple? Maybe I'm neglecting some other intensity dependent effect?)
- Acquire data for Q20 SPS.
- HEADTAIL studies to understand differences between measured slopes and simulated slopes.
- Understand resistive wall effects on measurements.
- Your suggestions are welcome!

Thanks!



Measurement with two bunches V plane



Using two bunches whose the leading one is bringing all the charge, and the trailing one is used as probe, we could measure the effects seen by the probe.





- Bunches are separated of half the machine (1us).
- Kicker is acting horizontally only on the trailing.
- By coupling we measure the trailing in vertical plane.
- Scan in intensity from 1e12 to 6e12.

Measurement with two bunches V plane





- Tune shift is due to coupled bunch effects.
- Is going up as corresponds to the horizontal tune.
- Is considerably reduced respect to the single bunch case.
- Imposed NSR~10% led to $\sigma_{\Delta \varphi} \sim 0.002$ as expected.



Unfortunately, being the tune shift lower, the error bars become considerably big... Q20 13/02//2013

